



# RADIO TEST REPORT

Test Report No. : 28KE0107-HO-01-D

Applicant : Sony Computer Entertainment Inc.  
Type of Equipment : PLAYSTATION®3  
Model No. : CECHL01  
FCC ID : AK8CBEH1500  
Test regulation : FCC Part 15 Subpart C 2008  
Section 15.207, Section 15.247  
Test Result : Complied

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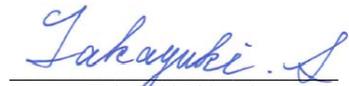
Date of test:

June 17 to July 2, 2008

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NVLAP LAB CODE: 200572-0

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## **SECTION 1: Customer information**

Company Name	Sony Computer Entertainment Inc.
Brand Name	SONY
Address	2-6-21 Minamiaoyama, Minato-ku, Tokyo, 107-0062, Japan
Telephone Number	+81-3-6438-8023
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Contact Person	Akiko Tsukada

## **SECTION 2: Equipment under test (E.U.T.)**

### **2.1 Identification of E.U.T.**

Type of Equipment	PLAYSTATION®3
Model No	CECHL01
Serial No	1040132: Used for Antenna Terminal Conducted tests 1040133: Used for Conducted emission and Radiated spurious emission test (Power Supply: SONY) 1040090: Used for Conducted emission (Power Supply: Delta)
BT Module	Module 3
Rating	AC 120V, 60Hz
Country of Manufacture	JAPAN/CHINA
Receipt Date of Sample	June 16, 2008
Condition of EUT	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	No modification by the test lab.

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## 2.2 Product Description

Model: CECHL01, referred to as the EUT in this report, is a PLAYSTATION®3.

The EUT contains Bluetooth (Ver. 2.0+EDR) module and IEEE802.11b/g WLAN module. Those modules do not transmit simultaneously.

Clock Frequencies are CPU: 3.2GHz(CPU), 66MHz(ATA), 133MHz(ATA), 33MHz(PCI), and 750MHz(SATA1).

### Bluetooth (Ver. 2.0+EDR)

Equipment Type	Transceiver
Frequency of Operation	2402-2480MHz
Type of Modulation	FHSS (GFSK, $\pi/4$ -DQPSK, 8DPSK)
Bandwidth & Channel spacing	1MHz & 1MHz
Power Supply (inner)	DC3.3V
Antenna Type	PWB Pattern Antenna
Antenna Gain	3.33 dBi (max)
Antenna Connector Type	N/A

### IEEE802.11b/g WLAN

Equipment Type	Transceiver	
Frequency of Operation	2412-2462MHz	
Type of Modulation	DSSS/OFDM	
Bandwidth & Channel spacing	20MHz & 5MHz	
Power Supply (inner)	DC 3.3V/DC1.3V	
Antenna Type	ANT 0: PWB Pattern Antenna	ANT 1: Reverse F Antenna
Antenna Gain	ANT 0: 2.01 dBi (max)	ANT 1: 1.48 dBi (max)
Antenna Connector Type	ANT 0: N/A	ANT 1: U.FL

For IEEE802.11b/g WLAN part, please see UL Japan, Inc. Test Report Number: 28KE0107-HO-01-A.

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### **SECTION 3: Test specification, procedures & results**

#### **3.1 Test Specification**

Test Specification : FCC Part15 Subpart C: 2008, final revised on May 19, 2008

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators  
Section 15.207 Conducted limits  
Section 15.247 Operation within the bands 902-928MHz,  
2400-2483.5MHz, and 5725-5850MHz

#### **FCC 15.31 (e)**

This EUT provides stable voltage(DC3.3V) constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

#### **FCC Part 15.203 Antenna requirement**

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.2 Procedures and results

No.	Item	Procedure	ification	Remarks	Deviation	Worst Margin	Results			
1	Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements	FCC: Section 15.207	-	N/A	[QP] 16.3dB 0.20041MHz, N, Ch: Mid, BDR, Tx, Power Supply: Delta [AV] 8.7dB 0.56253MHz, N, Ch: Mid, EDR, Tx, Power Supply: Delta	Complied			
		IC: RSS-Gen 7.2.2	IC: RSS-Gen 7.2.2							
2	Carrier Frequency Separation	FCC: FCC Public Notice DA 00-705	FCC: Section 15.247(a)(1)	Conducted	N/A	See data.	Complied			
		IC: -	IC: RSS-210 A8.1 (b)							
3	20dB Bandwidth	FCC: FCC Public Notice DA 00-705	FCC: Section 15.247(a)(1)	Conducted	N/A		See data.	Complied		
		IC: -	IC: RSS-210 A8.1 (a)							
4	Number of Hopping Frequency	FCC: FCC Public Notice DA 00-705	FCC: Section 15.247(a)(1)(iii)	Conducted	N/A			See data.	Complied	
		IC: -	IC: RSS-210 A8.1 (d)							
5	Dwell time	FCC: FCC Public Notice DA 00-705	FCC: Section 15.247(a)(1)(iii)	Conducted	N/A				See data.	Complied
		IC: -	IC: RSS-210 A8.1 (d)							
6	Maximum Peak Output Power	FCC: FCC Public Notice DA 00-705	FCC: Section 15.247(b)(1)	Conducted	N/A	See data.				Complied
		IC: RSS-Gen 4.8	IC: RSS-210 A8.4 (2)							
7	Band Edge Compliance	FCC: FCC Public Notice DA 00-705	FCC: Section 15.247(d)	Conducted	N/A		See data.			Complied
		IC: -	IC: RSS-210 A8.5							
8	Spurious Emission	FCC: FCC Public Notice DA 00-705	FCC: Section 15.247(d)	Conducted/ Radiated	N/A			See data.		Complied
		IC: RSS-Gen 4.9 RSS-Gen 4.10	IC: RSS-210 A8.5 RSS-Gen 7.2.1 and 7.2.3							

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

\* These tests were performed without any deviations from test procedure except for additions or exclusions.

\* In case any questions arise about test procedure, ANSI C63.4: 2003 is also referred.

### 3.3 Addition to standards

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied Band Width	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	Conducted	N/A	N/A	N/A

### 3.4 Uncertainty

#### EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room	Conducted emission	Radiated emission (10m*)				Radiated emission (3m*)			Radiated emission (3m*)	
	150kHz-30MHz	9kHz-30MHz	30MHz-300MHz	300MHz-1GHz	9kHz-30MHz	30MHz-300MHz	300MHz-1GHz	1GHz-18GHz	18GHz-40GHz	
No.1 semi-anechoic chamber (±)	3.7dB	3.1dB	4.4dB	4.2dB	3.2dB	3.8dB	3.9dB	5.9dB	6.1dB	
No.2 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	4.4dB	4.0dB	5.9dB	6.1dB	
No.3 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	4.6dB	4.0dB	5.9dB	6.1dB	
No.4 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	3.9dB	3.9dB	5.9dB	6.1dB	

\*10m/3m = Measurement distance

#### Conducted emission test

The data listed in this test report has enough margin, more than the site margin.

#### Radiated emission test(3m)

[Tx] The data listed in this report meets the limits unless the uncertainty is taken into consideration.

[Rx] The data listed in this test report has enough margin, more than the site margin.

#### Other test except Conducted Emission and Spurious Emission (Radiated)

The measurement uncertainty for this test is 3.0dB.

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### 3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

\* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

### 3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

## SECTION 4: Operation of E.U.T. during testing

### 4.1 Operating Mode(s)

Test	Mode	Tested frequency
Conducted Emission	Bluetooth Transmitting (Tx), Payload: PRBS9 (Hopping OFF) - DH5 - 3-DH5	2402MHz(L) 2441MHz(M) 2480MHz(H)
	Bluetooth Receiving (Rx)	2441MHz(M)
Carrier Frequency Separation	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping ON) - DH5 - 3-DH5	2402MHz(L) 2441MHz(M) 2480MHz(H)
	Inquiry	2441MHz(M)
20dB Bandwidth	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping OFF) - DH5 - 3-DH5	2402MHz(L) 2441MHz(M) 2480MHz(H)
	Inquiry	2441MHz(M)
Number of Hopping Frequency	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping ON) - DH5 - 3-DH5 Inquiry	-
Dwell time	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping ON) - DH1 - DH3 - DH5 - 3-DH1 - 3-DH3 - 3-DH5 Inquiry	-
Maximum Peak Output Power	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping OFF) - DH5 - 2-DH5 - 3-DH5	2402MHz(L) 2441MHz(M) 2480MHz(H)
	Inquiry	2441MHz(M)
Spurious Emission (Radiated/Conducted)	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping OFF) - DH5 - 3-DH5	2402MHz(L) 2441MHz(M) 2480MHz(H)
	Bluetooth Receiving (Rx)	2441MHz(M)
Band Edge Compliance (Conducted)	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping ON/Hopping OFF) - DH5 - 3-DH5	2402MHz(L) 2480MHz(H)
	(Radiated)	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping OFF) - DH5 - 3-DH5
99% Occupied Bandwidth	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping ON/Hopping OFF) - DH5 - 3-DH5	2402MHz(L) 2441MHz(M) 2480MHz(H)

\*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload (except Dwell time test)

**Remarks:** Test was not performed at AFH mode, because the decrease of number of channel (min: 20ch) at AFH mode does not influence on the output power and bandwidth of the EUT. However, the limit level 125mW of AFH mode was used due to the overlap of the bandwidth.

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## 4.2 Configuration and peripherals

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## **SECTION 5: Conducted Emission**

### **Test Procedure and conditions**

EUT was placed on a wooden table of nominal size, 1.0m by 1.5m, raised 80cm above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

#### For the tests on EUT with other peripherals (as a whole system)

I/O cable and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber or a Measurement Room.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

**Detector** : quasi-peak and average detector (IF BW 9 kHz)  
**Measurement range** : 0.15-30MHz  
**Test data** : APPENDIX 2  
**Test result** : Pass

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**SECTION 6: Spurious Emission**

**[Conducted]**

**Test Procedure**

The Out of Band Emission was measured with a spectrum analyzer connected to the antenna port. The following spectrum analyzer setting was used:

- RBW: 100kHz
- VBW: 300kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

**Test data : APPENDIX 2**

**Test result : Pass**

**[Radiated]**

**Test Procedure**

EUT was placed on an urethane platform of nominal size, 1.0m by 1.5m, raised 80cm above the conducting ground plane. The Radiated Electric Field Strength intensity has been measured in a Semi Anechoic Chamber with a ground plane and at a distance of 3m(Below 10GHz) and 1m(Upper 10GHz).

The height of the measuring varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

**20dBc was applied to the frequency over the limit of FCC 15.209 / Table 2 of RSS-210 2.7 (IC) and outside the restricted band of FCC15.205 / Table 1 of RSS-210 2.7 (IC).**

Frequency	Below 1GHz	Above 1GHz
Instrument used	Test Receiver	Spectrum Analyzer
Detector	QP: BW 120kHz(T/R)	PK: RBW:1MHz/VBW: 1MHz
IF Bandwidth		AV: RBW:1MHz/VBW:10Hz
		20dBc : RBW:100kHz/VBW:300kHz

- The carrier level and noise levels were confirmed at each position of X, Y axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

**Test data : APPENDIX 2**

**Test result : Pass**

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## **SECTION 7: Bandwidth**

### **20 dB Bandwidth**

#### **Test Procedure**

The bandwidth was measured with a spectrum analyzer connected to the antenna port.  
The following spectrum analyzer setting was used:

- Span: 3MHz or 2.5MHz
- RBW: 30kHz
- VBW: 30kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

**Test data** : APPENDIX 2  
**Test result** : Pass

### **99% Occupied Bandwidth**

#### **Test Procedure**

The bandwidth was measured with a spectrum analyzer connected to the antenna port.  
The following spectrum analyzer setting was used:

- Span: Enough width to display 20dB Bandwidth
- RBW: as close to 1% of the Span as is possible without being below 1%
- VBW: Three times of RBW
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

**Test data** : APPENDIX 2  
**Test result** : Pass

## **SECTION 8: Maximum Peak Output Power**

#### **Test Procedure**

The Maximum Peak Output Power was measured with a power meter (tested bandwidth: 50MHz) connected to the antenna port.

**Test data** : APPENDIX 2  
**Test result** : Pass

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## **SECTION 9: Carrier Frequency Separation**

### **Test Procedure**

The carrier frequency separation was measured with a spectrum analyzer connected to the antenna port.  
The following spectrum analyzer setting was used:

- Span: 3MHz or 5MHz
- RBW: 100kHz
- VBW: 300kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

**Test data** : APPENDIX 2  
**Test result** : Pass

## **SECTION 10: Number of Hopping Frequency**

### **Test Procedure**

The Number of Hopping Frequency was measured with a spectrum analyzer connected to the antenna port.  
The following spectrum analyzer setting was used:

- Span: 30MHz
- RBW: 300kHz
- VBW: 1MHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

**Test data** : APPENDIX 2  
**Test result** : Pass

## **SECTION 11: Dwell time**

### **Test Procedure**

The Dwell time was measured with a spectrum analyzer connected to the antenna port.  
The following spectrum analyzer setting was used:

- Span: Zero Span
- RBW: 1MHz
- VBW: 3MHz
- Sweep: as necessary to capture the entire dwell time per hopping channel
- Detector: Peak
- Trace: Max Hold

**Test data** : APPENDIX 2  
**Test result** : Pass